

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>	
	10/705,238	JANG ET AL.	
	<b>Examiner</b>	Art Unit	
	Matthew G. Kayrish	2627	

<b>INTERFERENCE SEARCHED</b>			
Class	Subclass	Date	Examiner